

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/653,719 CHEN ET AL.	
		Examiner	Art Unit	Page 1 of 1 John P. Leubecker 3739

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,765,561	06-1998	Chen et al.	600/407
*	C	US-5,704,897	01-1998	Truppe, Michael J.	600/117
*	D	US-5,558,619	09-1996	Kami et al.	600/146
*	E	US-5,526,814	06-1996	Cline et al.	600/411
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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